

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/839,179	BARKER ET AL.	
Examiner	Art Unit	
Eric Chang	2116	

SEARCHED					
Class	Subclass	Date	Examiner		
713	320	7/5/2005	EC		
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INI	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST USPAT/PGPUB EPO/JPO	7/5/2005	EC		
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